

# C3M0040120J1

Silicon Carbide Power MOSFET  
C3M™ MOSFET Technology  
N-Channel Enhancement Mode

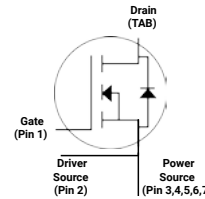


TO-263-7L XL



## Features

- 3<sup>rd</sup> generation SiC MOSFET technology
- Optimized package with separate driver source pin
- High blocking voltage with low on-resistance
- High speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery ( $Q_{rr}$ )
- Halogen free, RoHS compliant



Package Types: TO-263-7L XL  
PN's: C3M0040120J1

Wolfspeed, Inc. is in the process of rebranding its products and related materials pursuant to the entity name change from Cree, Inc. to Wolfspeed, Inc. During this transition period, products received may be marked with either the Cree name and/or logo or the Wolfspeed name and/or logo.

## Applications

- Datacenter and telecom power supplies
- EV battery chargers
- High voltage DC/DC converters
- Energy storage systems
- Solar inverters

## Benefits

- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency

## Key Parameters

Parameter	Symbol	Min.	Typ.	Max	Unit	Conditions	Note
Drain - Source Voltage	$V_{DS}$			1200	V	$T_C = 25^\circ\text{C}$	
Maximum Gate - Source Voltage	$V_{GS(max)}$	-8		+19		Transient	
Operational Gate-Source Voltage	$V_{GS op}$		-4/15			Static	Note 1
DC Continuous Drain Current	$I_D$			64	A	$V_{GS} = 15\text{ V}, T_C = 25^\circ\text{C}, T_J \leq 150^\circ\text{C}$	Fig. 19 Note 2
				42		$V_{GS} = 15\text{ V}, T_C = 100^\circ\text{C}, T_J \leq 150^\circ\text{C}$	
Pulsed Drain Current	$I_{DM}$			100		$t_{Pmax}$ limited by $T_{Jmax}$ $V_{GS} = 15\text{ V}, T_C = 25^\circ\text{C}$	Fig. 22
Power Dissipation	$P_D$			272	W	$T_C = 25^\circ\text{C}, T_J = 150^\circ\text{C}$	Fig. 20
Operating Junction Temperature	$T_J$			-40 to +175	°C		
Case and Storage Temperature	$T_C, T_{stg}$			-40 to 150			
Solder Temperature	$T_L$			260		According to JEDEC J-STD-020	

Note (1): Recommended turn-on gate voltage is 15V with  $\pm 5\%$  regulation tolerance, see Application Note PRD-04814 for additional details

Note (2): Verified by design


**Electrical Characteristics** ( $T_C = 25\text{ }^\circ\text{C}$  Unless Otherwise Specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions	Note
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	1200				$V_{GS} = 0\text{ V}, I_D = 100\text{ }\mu\text{A}$	
Gate Threshold Voltage	$V_{GS(th)}$	1.8	2.7	3.6	V	$V_{DS} = V_{GS}, I_D = 9.2\text{ mA}$	Fig. 11
			2.2			$V_{DS} = V_{GS}, I_D = 9.2\text{ mA}, T_J = 150\text{ }^\circ\text{C}$	
Zero Gate Voltage Drain Current	$I_{DSS}$		1	50	$\mu\text{A}$	$V_{DS} = 1200\text{ V}, V_{GS} = 0\text{ V}$	
Gate-Source Leakage Current	$I_{GSS}$		10	250	nA	$V_{GS} = 15\text{ V}, V_{DS} = 0\text{ V}$	
Drain-Source On-State Resistance	$R_{DS(on)}$		40	53.5	m $\Omega$	$V_{GS} = 15\text{ V}, I_D = 33.3\text{ A}$	Fig. 4, 5, 6
			60			$V_{GS} = 15\text{ V}, I_D = 33.3\text{ A}, T_J = 150\text{ }^\circ\text{C}$	
Transconductance	$g_{fs}$		21		S	$V_{DS} = 20\text{ V}, I_{DS} = 33.3\text{ A}$	Fig. 7
			20			$V_{DS} = 20\text{ V}, I_{DS} = 33.3\text{ A}, T_J = 150\text{ }^\circ\text{C}$	
Input Capacitance	$C_{iss}$		2900		pF	$V_{GS} = 0\text{ V}, V_{DS} = 1000\text{ V}$ $f = 100\text{ kHz}$ $V_{AC} = 25\text{ mV}$	Fig. 17, 18
Output Capacitance	$C_{oss}$		103				
Reverse Transfer Capacitance	$C_{rss}$		5				
$C_{oss}$ Stored Energy	$E_{oss}$		60		$\mu\text{J}$		Fig. 16
Turn-On Switching Energy (Body Diode FWD)	$E_{ON}$		339		$\mu\text{J}$	$V_{DS} = 800\text{ V}, V_{GS} = -4\text{ V}/15\text{ V},$ $I_D = 33.3\text{ A},$ $R_{G(ext)} = 2.5\text{ }\Omega, L = 99\text{ }\mu\text{H}$	Fig. 26
Turn-Off Switching Energy (Body Diode FWD)	$E_{OFF}$		67				
Turn-On Delay Time	$t_{d(on)}$		13		ns	$V_{DD} = 800\text{ V}, V_{GS} = -4\text{ V}/15\text{ V}$ $R_{G(ext)} = 2.5\text{ }\Omega, I_D = 33.3\text{ A}, L = 99$ Timing Relative to $V_{DS}$ , Inductive Load	Fig. 27
Rise Time	$t_r$		18				
Turn-Off Delay Time	$t_{d(off)}$		22				
Fall Time	$t_f$		8				
Internal Gate Resistance	$R_{G(int)}$		3.5		$\Omega$	$f = 1\text{ MHz}, V_{AC} = 25\text{ mV}$	
Gate to Source Charge	$Q_{gs}$		35		nC	$V_{DS} = 800\text{ V}, V_{GS} = -4\text{ V}/15\text{ V}$ $I_D = 33.3\text{ A}$ Per IEC60747-8-4 pg 21	Fig. 12
Gate to Drain Charge	$Q_{gd}$		27				
Total Gate Charge	$Q_g$		94				



### Reverse Diode Characteristics ( $T_c = 25^\circ\text{C}$ Unless Otherwise Specified)

Parameter	Symbol	Typ.	Max.	Unit	Test Conditions	Note
Diode Forward Voltage	$V_{SD}$	5.5		V	$V_{GS} = -4\text{ V}, I_{SD} = 20\text{ A}, T_J = 25^\circ\text{C}$	Fig. 8, 9, 10
		4.5			$V_{GS} = -4\text{ V}, I_{SD} = 20\text{ A}, T_J = 150^\circ\text{C}$	
Continuous Diode Forward Current	$I_S$		44	A	$V_{GS} = -4\text{ V}, T_c = 25^\circ\text{C}$	
Diode Pulse Current	$I_{S, pulse}$		100		$V_{GS} = -4\text{ V}, \text{Pulse Width } t_p \text{ Limited by } T_{Jmax}$	
Reverse Recovery Time	$t_{rr}$	11		ns	$V_{GS} = -4\text{ V}, I_{SD} = 33.3\text{ A}, V_R = 800\text{ V}$ $dif/dt = 9890\text{ A}/\mu\text{s}$	
Reverse Recovery Charge	$Q_{rr}$	323		nC		
Peak Reverse Recovery Current	$I_{rrm}$	52		A		
Reverse Recovery Time	$t_{rr}$	17		ns	$V_{GS} = -4\text{ V}, I_{SD} = 33.3\text{ A}, V_R = 800\text{ V}$ $dif/dt = 1815\text{ A}/\mu\text{s}$	
Reverse Recovery Charge	$Q_{rr}$	150		nC		
Peak Reverse Recovery Current	$I_{rrm}$	16		A		

### Thermal Characteristics

Parameter	Symbol	Typ.	Unit	Test Conditions	Note
Thermal Resistance from Junction to Case	$R_{\theta JC}$	0.46	$^\circ\text{C}/\text{W}$		Fig. 21
Thermal Resistance from Junction to Ambient	$R_{\theta JA}$	40			



Typical Performance

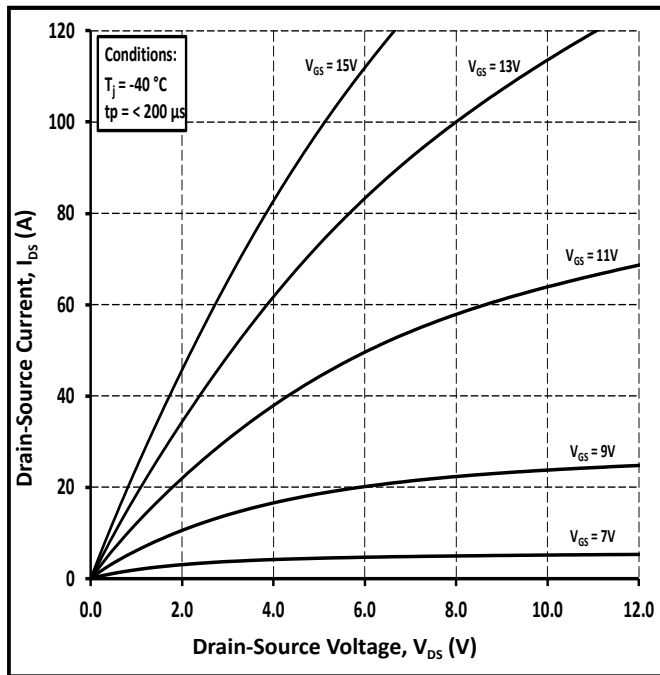


Figure 1. Output Characteristics  $T_j = -40\text{ }^\circ\text{C}$

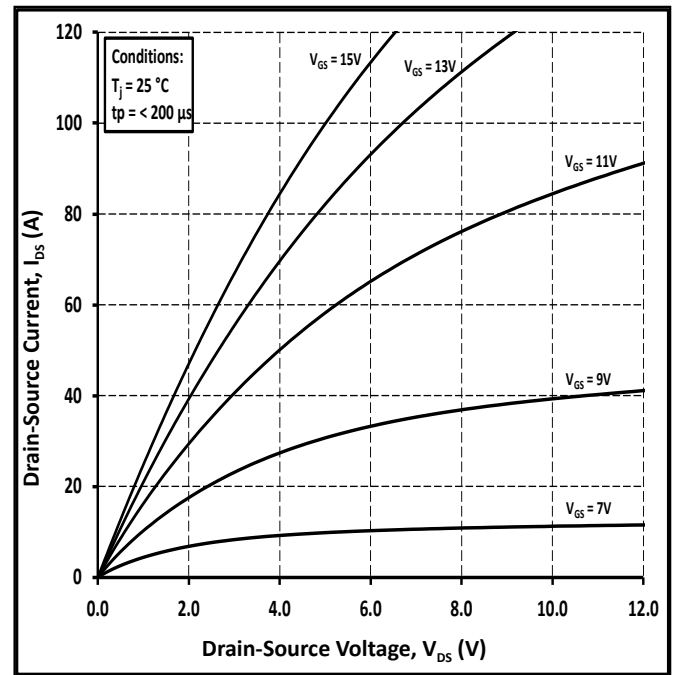


Figure 2. Output Characteristics  $T_j = 25\text{ }^\circ\text{C}$

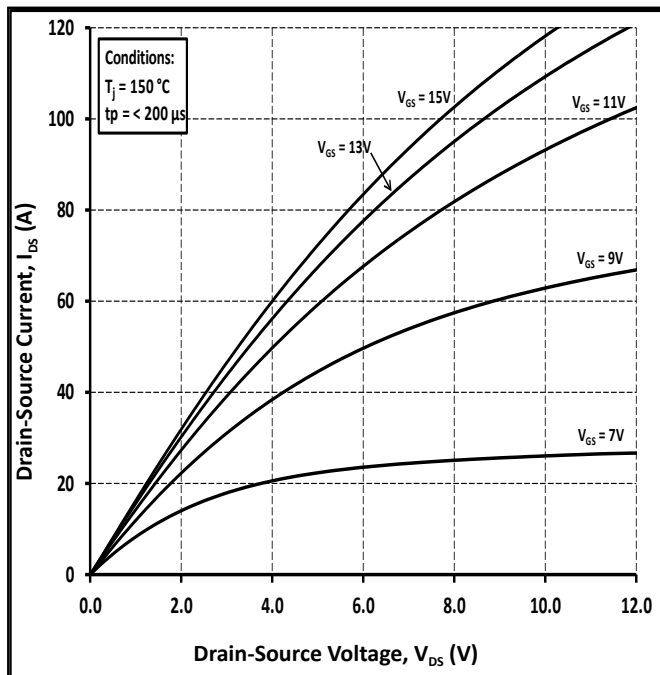


Figure 3. Output Characteristics  $T_j = 150\text{ }^\circ\text{C}$

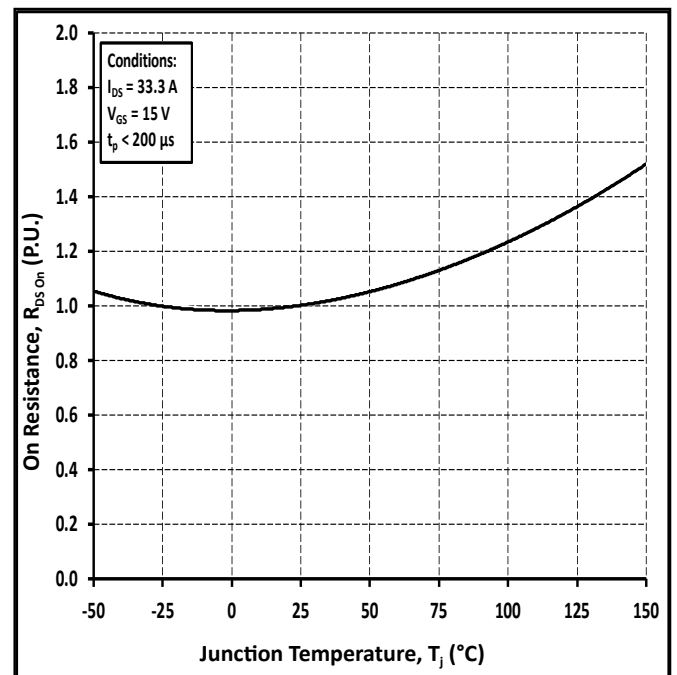


Figure 4. Normalized On-Resistance vs Temperature



Typical Performance

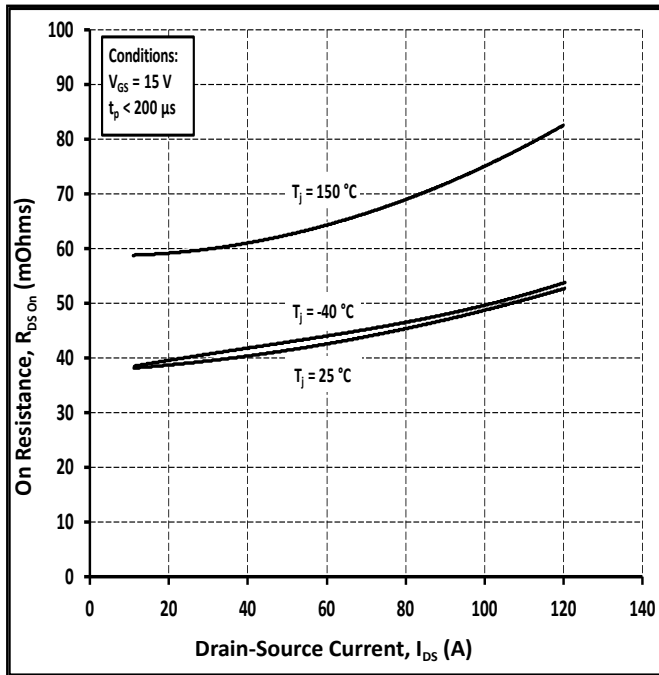


Figure 5. On-Resistance vs Drain Current for Various Temperatures

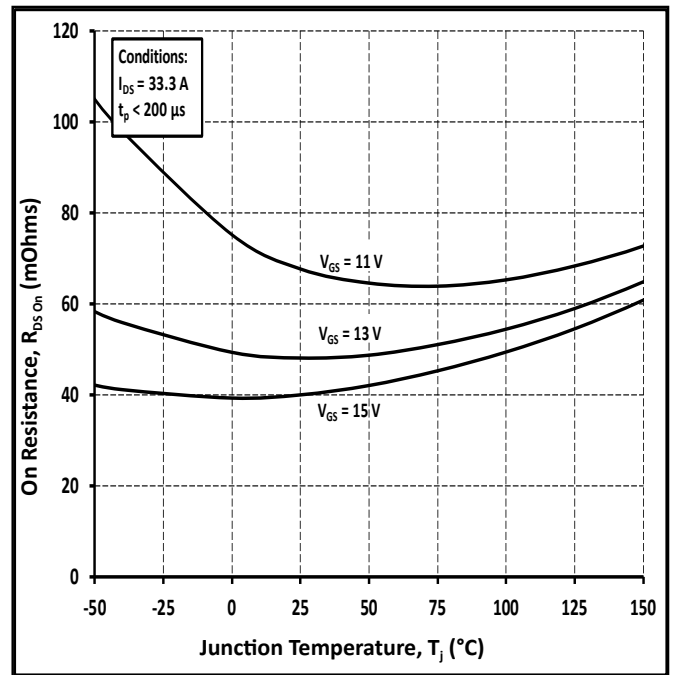


Figure 6. On-Resistance vs Temperature for Various Gate Voltage

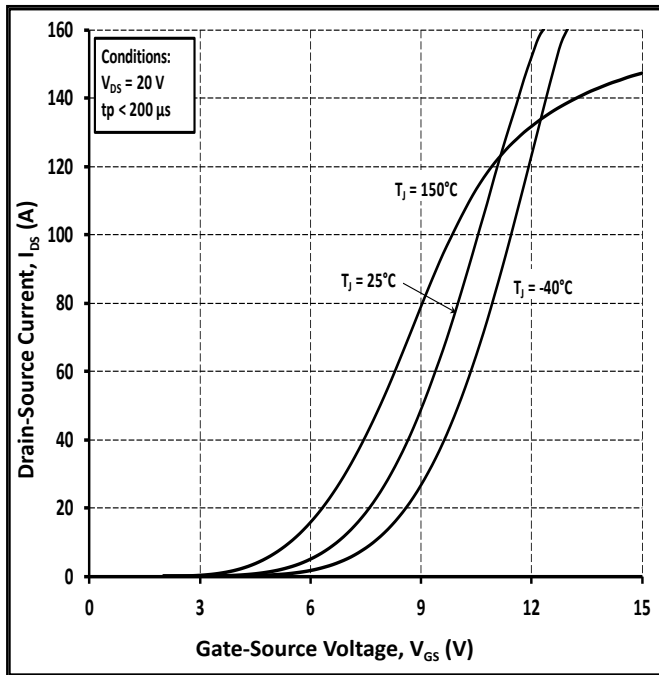


Figure 7. Transfer Characteristic for Various Junction Temperatures

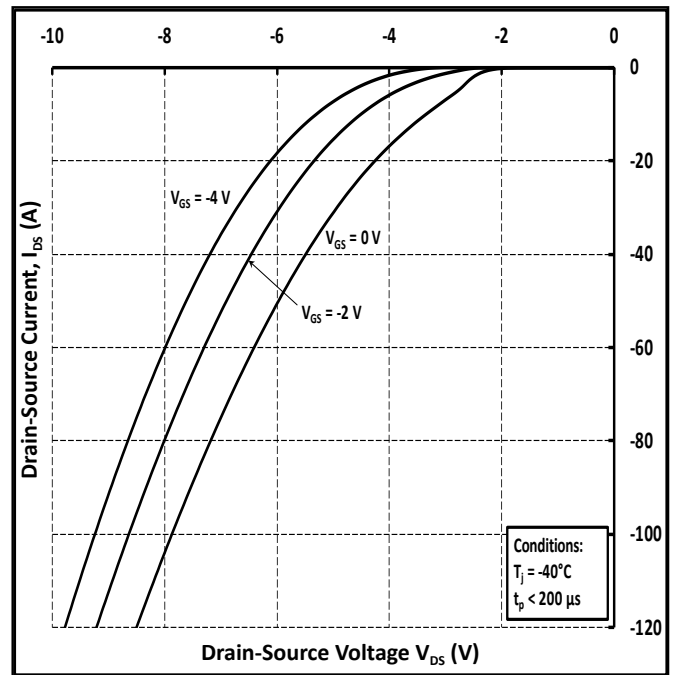


Figure 8. Body Diode Characteristic at -40 °C

Typical Performance

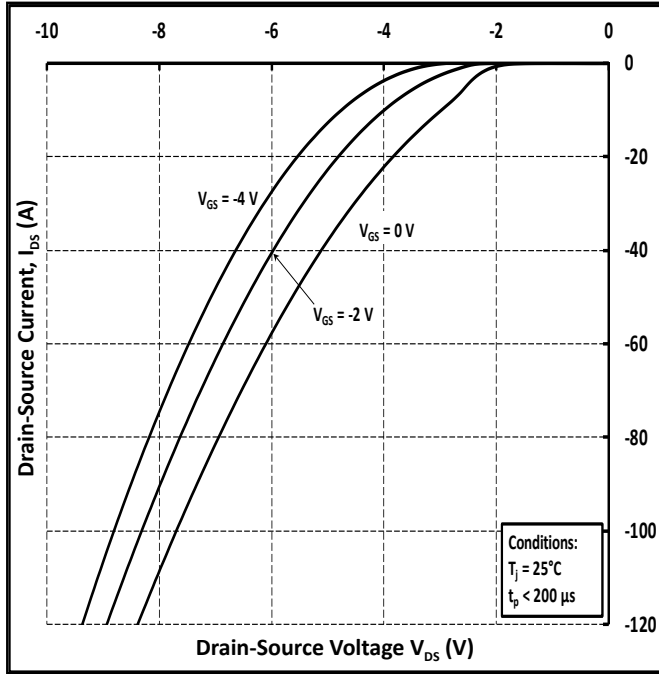


Figure 9. Body Diode Characteristic at 25 °C

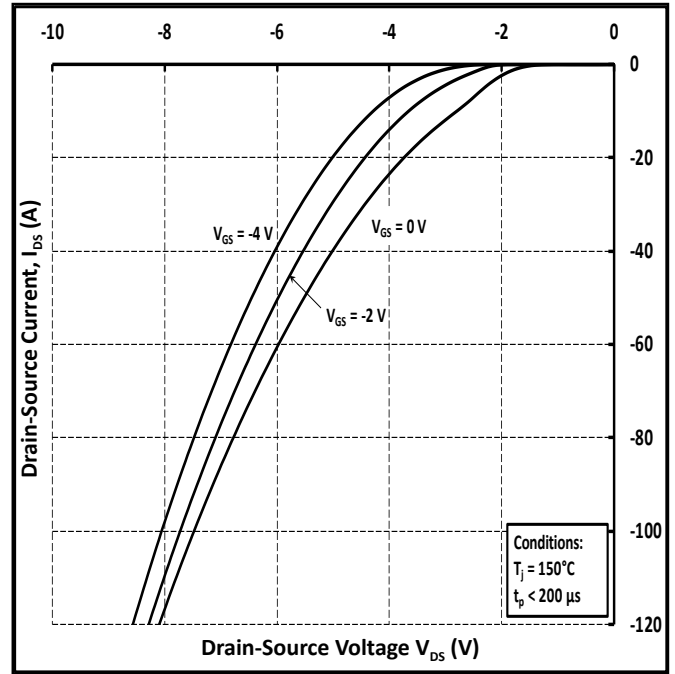


Figure 10. Body Diode Characteristic at 150 °C

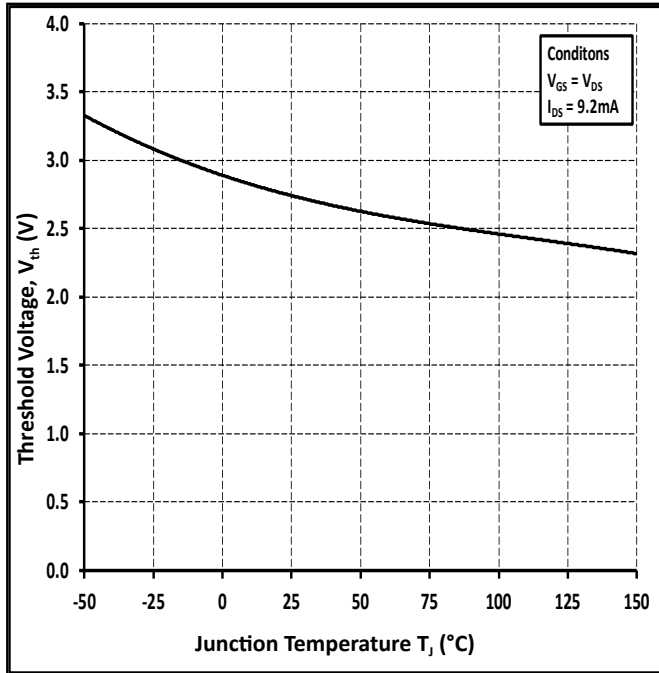


Figure 11. Threshold Voltage vs Temperature

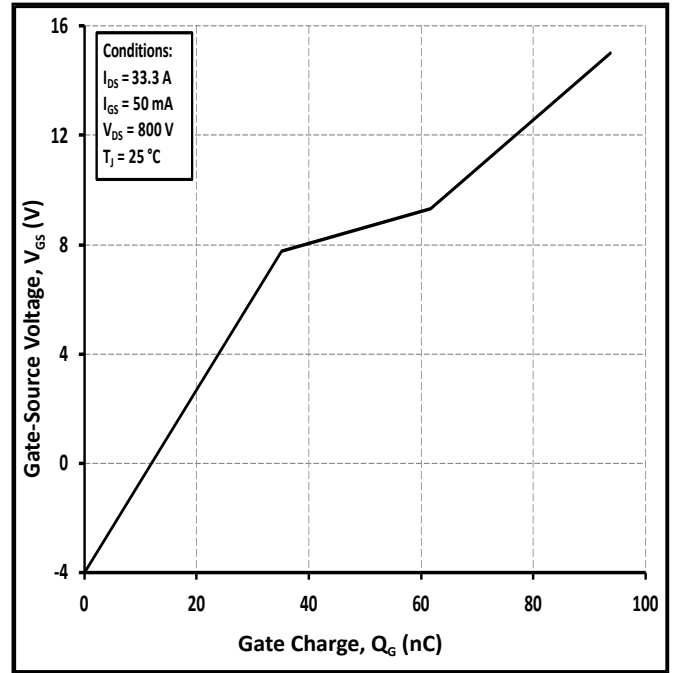


Figure 12. Gate Charge Characteristic

Typical Performance

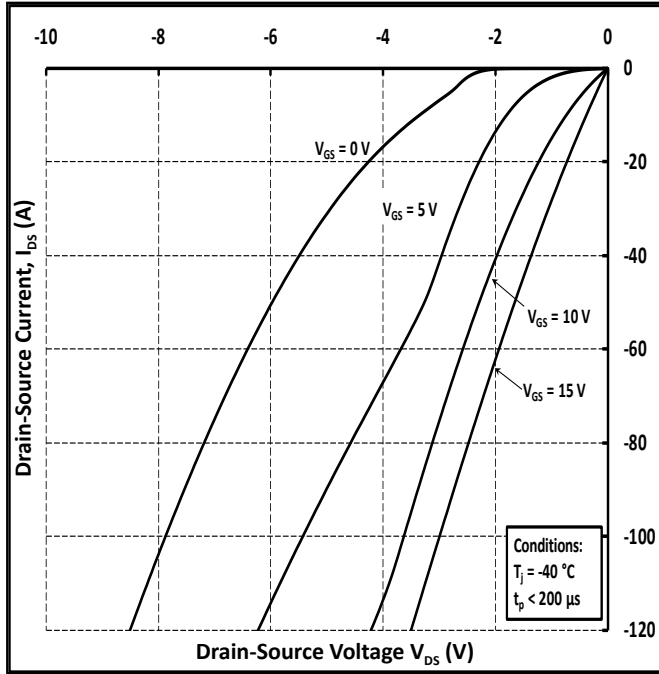


Figure 13. 3<sup>rd</sup> Quadrant Characteristic at  $-40\text{ }^\circ\text{C}$

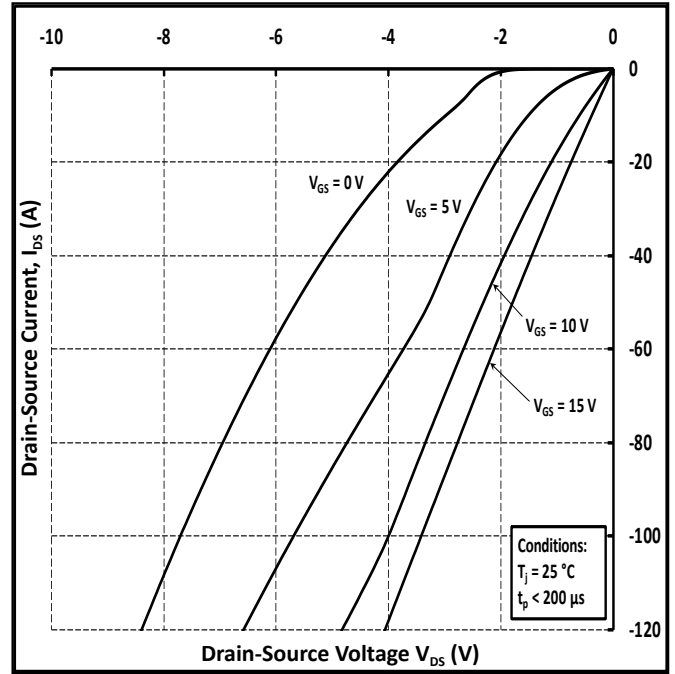


Figure 14. 3<sup>rd</sup> Quadrant Characteristic at  $25\text{ }^\circ\text{C}$

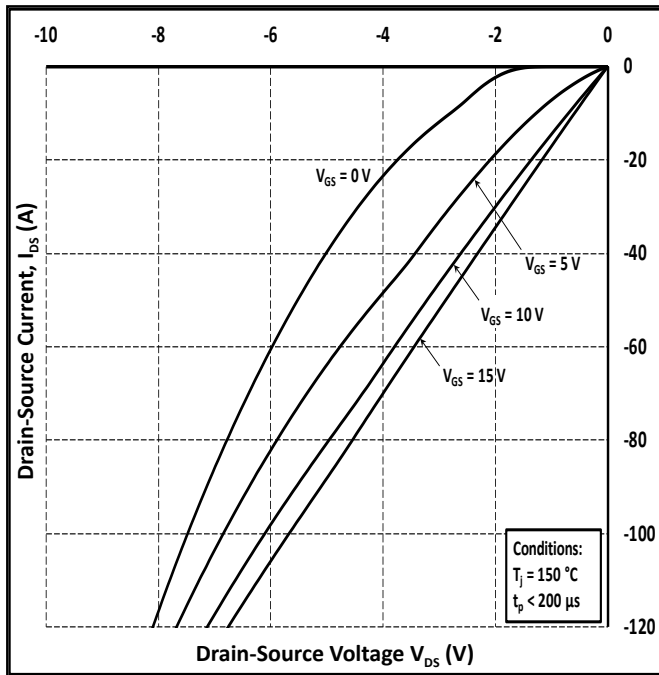


Figure 15. 3<sup>rd</sup> Quadrant Characteristic at  $150\text{ }^\circ\text{C}$

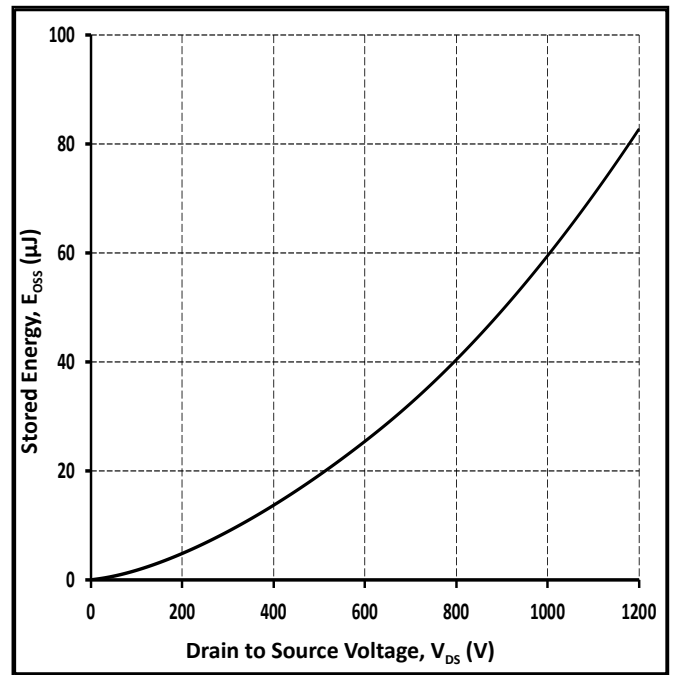


Figure 16. Output Capacitor Stored Energy

Typical Performance

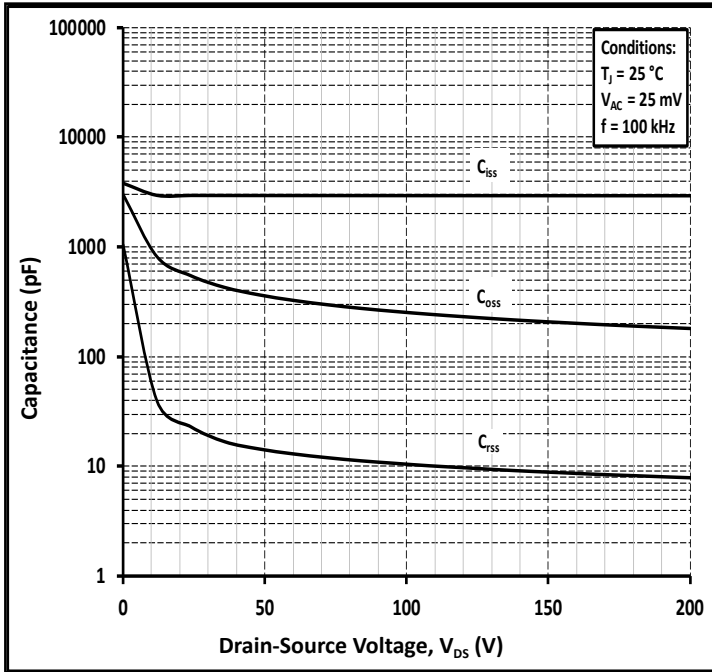


Figure 17. Capacitances vs Drain-Source Voltage (0-200 V)

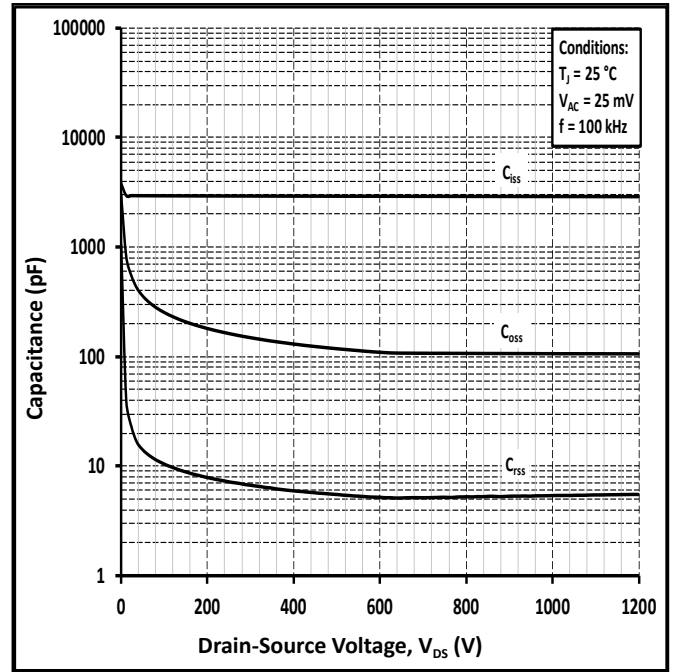


Figure 18. Capacitances vs Drain-Source Voltage (0-1200 V)

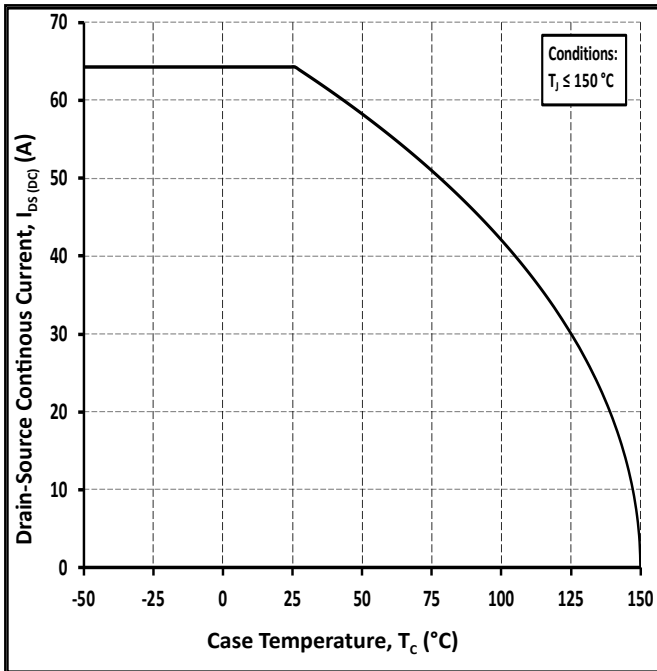


Figure 19. Continuous Drain Current Derating vs Case Temperature

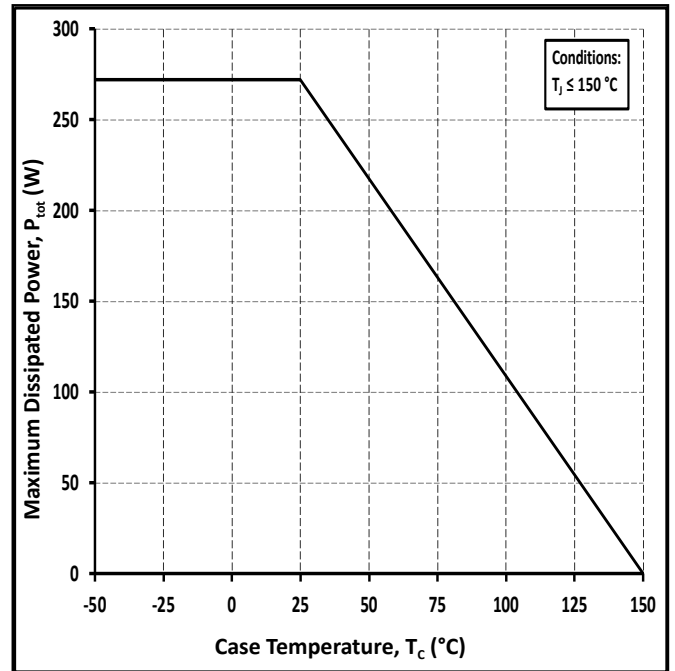


Figure 20. Maximum Power Dissipation Derating vs Case Temperature





Typical Performance

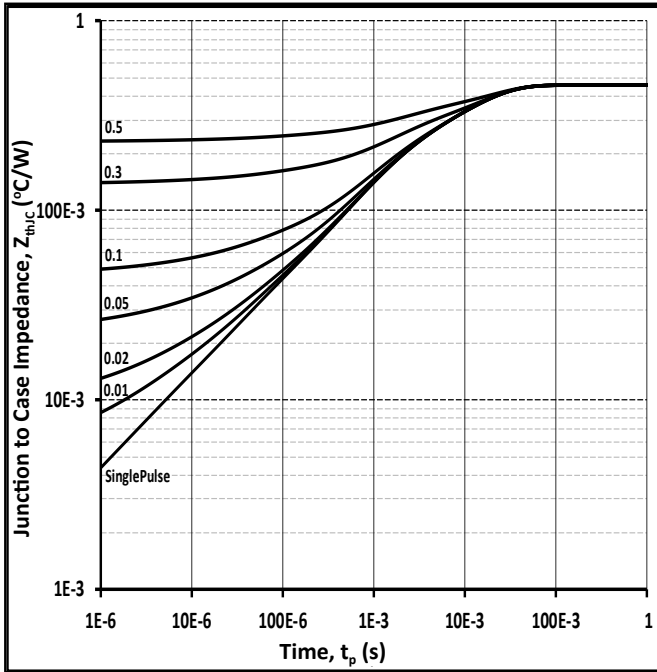


Figure 21. Transient Thermal Impedance (Junction - Case)

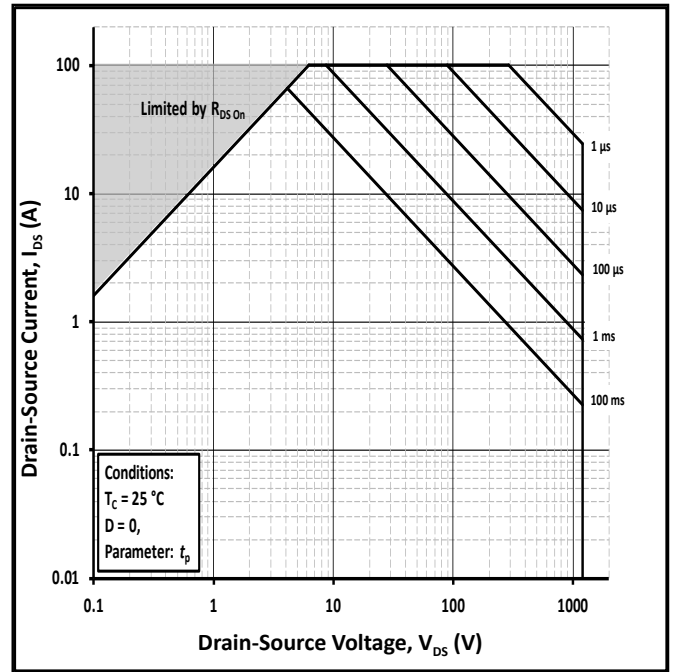


Figure 22. Safe Operating Area

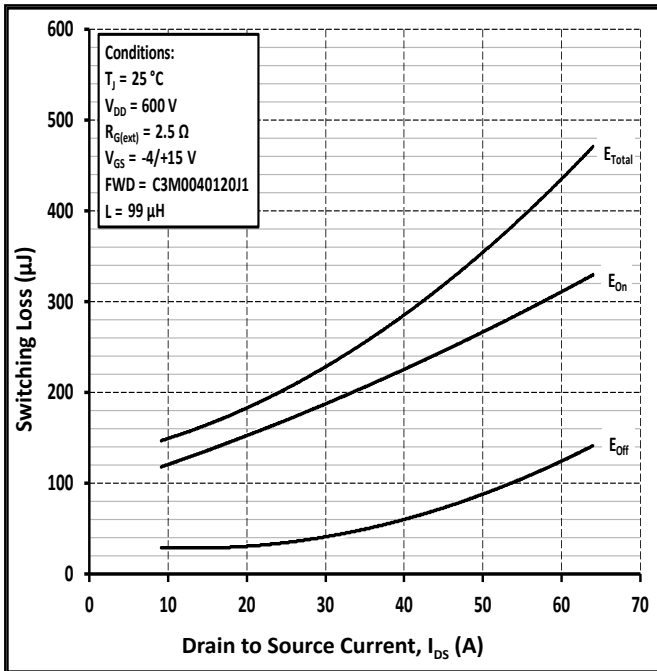


Figure 23. Clamped Inductive Switching Energy vs Drain Current ( $V_{DD} = 600\text{ V}$ )

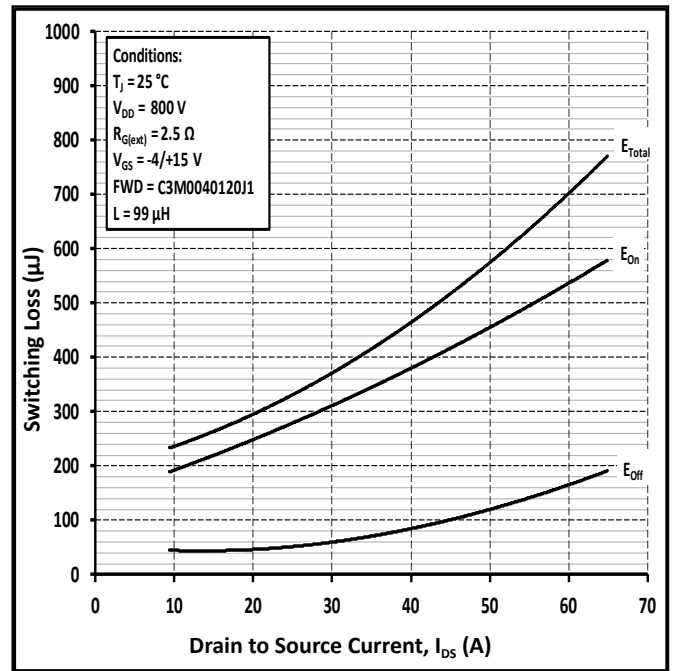


Figure 24. Clamped Inductive Switching Energy vs Drain Current ( $V_{DD} = 800\text{ V}$ )



Typical Performance

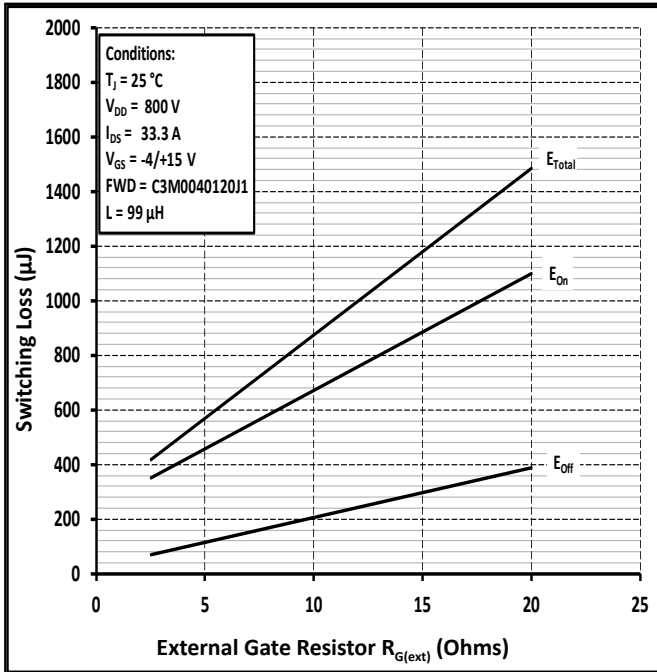


Figure 25. Clamped Inductive Switching Energy vs  $R_{G(ext)}$

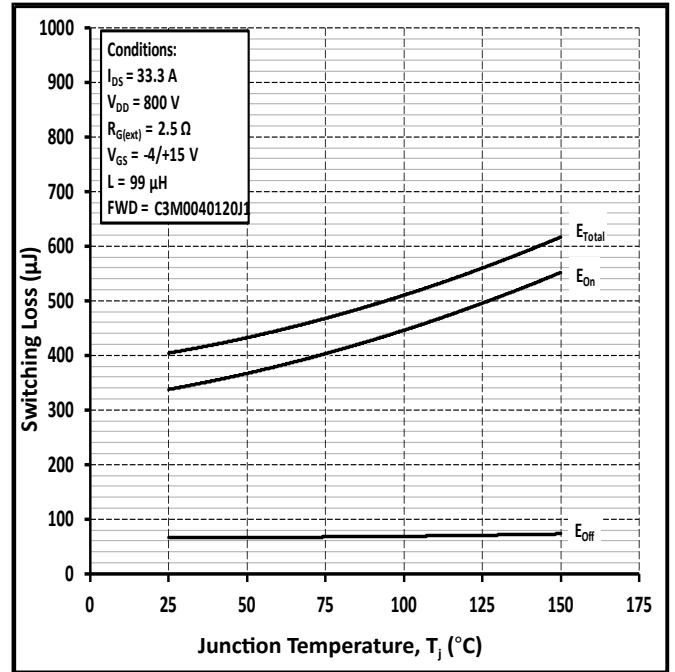


Figure 26. Clamped Inductive Switching Energy vs Temperature

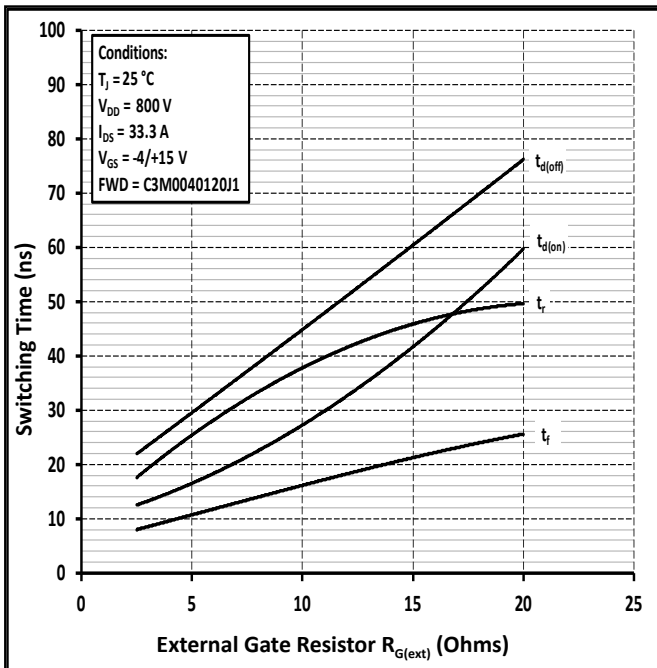


Figure 27. Switching Times vs  $R_{G(ext)}$

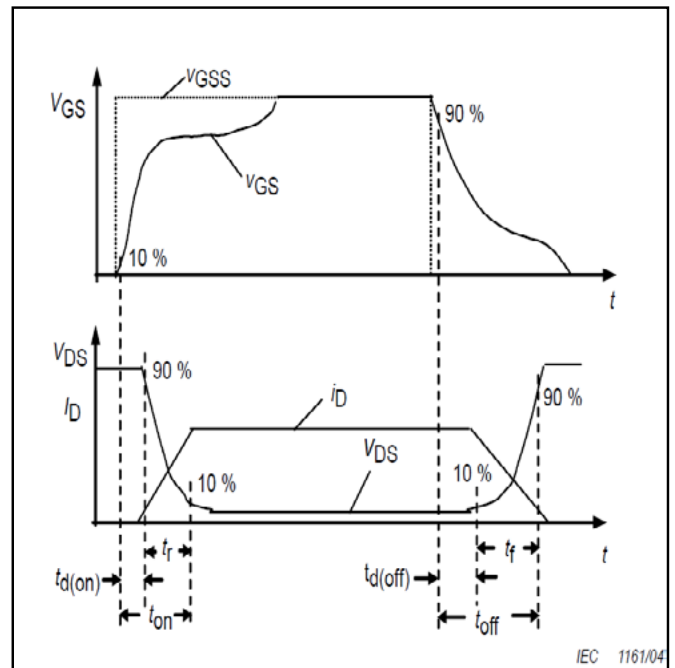


Figure 28. Switching Times Definition



**Test Circuit Schematic**

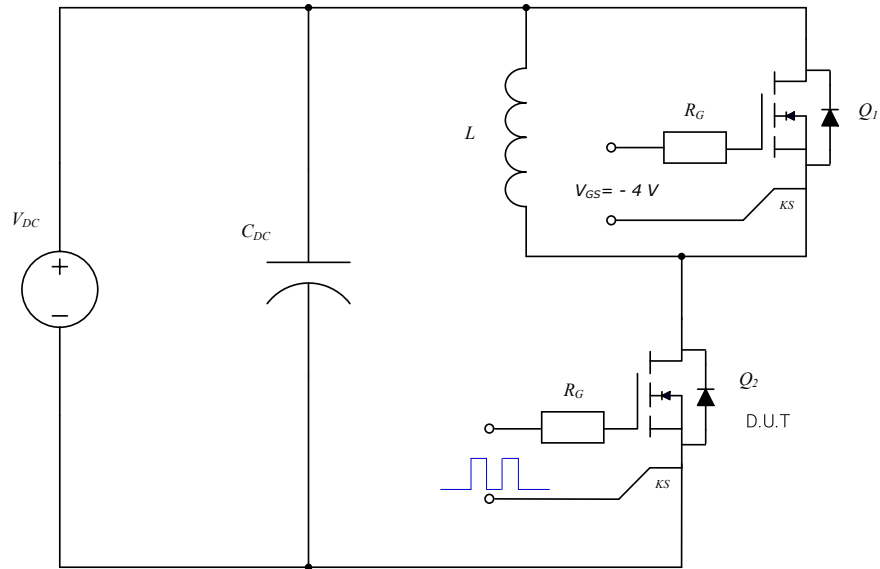


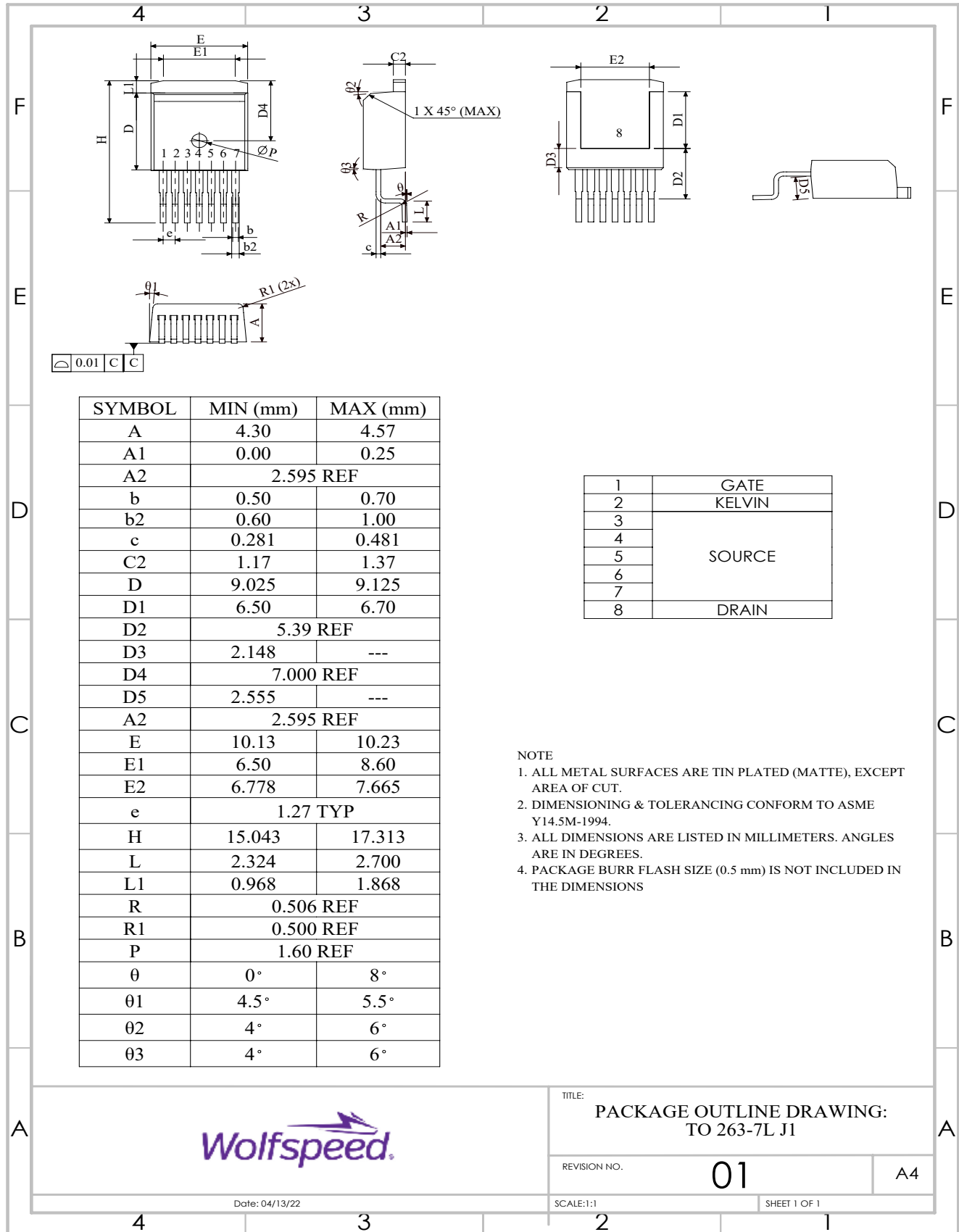
Figure 29. Clamped Inductive Switching Waveform Test Circuit

Note (3): Turn-off and Turn-on switching energy and timing values measured using SiC MOSFET body diode as shown above.



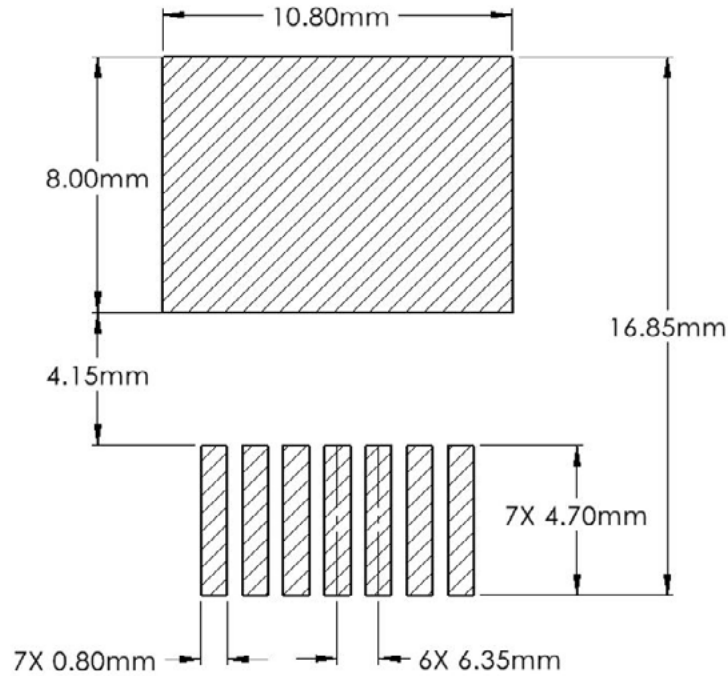
### Package Dimensions

Package: TO-263-7L XL





## Recommended Solder Pad Layout



## Revision History

Current Revision	Date of Release	Description of Changes
0	October-2021	Initial Release
1	N/A	Not Released
2	November-2023	Updated Wolfspeed branding, package drawing, package image, solder pad layout, added Rev history, Table 1 layout revised



## Notes & Disclaimer

---

This document and the information contained herein are subject to change without notice. Any such change shall be evidenced by the publication of an updated version of this document by Wolfspeed. No communication from any employee or agent of Wolfspeed or any third party shall effect an amendment or modification of this document. No responsibility is assumed by Wolfspeed for any infringement of patents or other rights of third parties which may result from use of the information contained herein. No license is granted by implication or otherwise under any patent or patent rights of Wolfspeed.

Notwithstanding any application-specific information, guidance, assistance, or support that Wolfspeed may provide, the buyer of this product is solely responsible for determining the suitability of this product for the buyer's purposes, including without limitation for use in the applications identified in the next bullet point, and for the compliance of the buyers' products, including those that incorporate this product, with all applicable legal, regulatory, and safety-related requirements.

This product has not been designed or tested for use in, and is not intended for use in, applications in which failure of the product would reasonably be expected to cause death, personal injury, or property damage, including but not limited to equipment implanted into the human body, life-support machines, cardiac defibrillators, and similar emergency medical equipment, aircraft navigation, communication, and control systems, aircraft power and propulsion systems, air traffic control systems, and equipment used in the planning, construction, maintenance, or operation of nuclear facilities.

### RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS2), as implemented January 2, 2013. RoHS Declarations for this product can be obtained from your Wolfspeed representative or from the Product Documentation sections of [www.wolfspeed.com](http://www.wolfspeed.com).

### REACH Compliance

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact your Wolfspeed representative to ensure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

### Contact info:

4600 Silicon Drive  
Durham, NC 27703 USA  
Tel: +1.919.313.5300  
[www.wolfspeed.com/power](http://www.wolfspeed.com/power)